Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,312	SCHOTTLER ET AL.	
Examiner	Art Unit	
Sunray Chang	2121	

SEARCHED				
Class	Subclass	Date	Examiner	
341	143	10/27/2006	sc	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (IŅCLUDING SEARCH		
	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	10/27/2006	sc
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